Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/543,190	TATEMATSU ET AL.		
Examiner	Art Unit		
Huan H. Tran	2861		

SEARCHED					
Class	Subclass	Date	Examiner		
347	212,155 156	1/4/2007	ннт		
399	320,322	1/4/2007	ННТ		
399	323	1/4/2007	ннт		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH N (INCLUDING SEAR)		')
	DATE	EXMR
(347/212,155,156 or 399/320,322,323).ccls.	1/4/2007	ннт
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